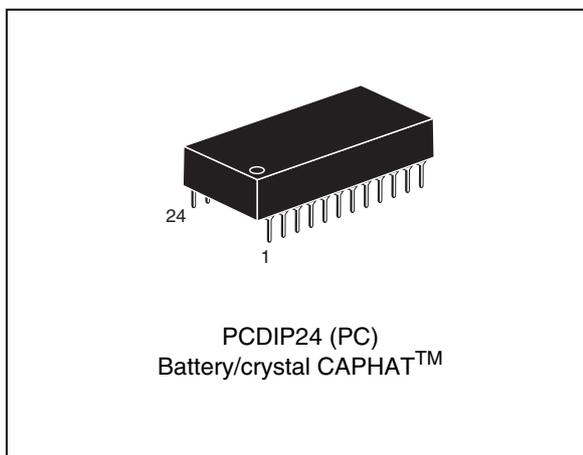


Serial access real-time clock (RTC) with integral backup battery and crystal

Datasheet – production data

Features

- Real-time clock (RTC) with backup battery integrated into package
- Uses M41T00S enhanced RTC with precision switchover reference
- 400 kHz I²C serial interface
- Automatic switchover and deselect circuitry with fixed reference voltage
 - V_{CC} = 2.7 to 5.5 V operating voltage range
 - 2.6 V (typ) power-fail deselect (switchover) threshold
- Counters for seconds, minutes, hours, day, date, month, year and century
- Software clock calibration
- Low operating current of 300 µA
- Oscillator stop detection
- Battery backup
- Operating temperature of 0 to 70 °C
- Self-contained battery and crystal in CAPHAT™ DIP package
- RoHS compliant
 - Lead-free second level interconnect



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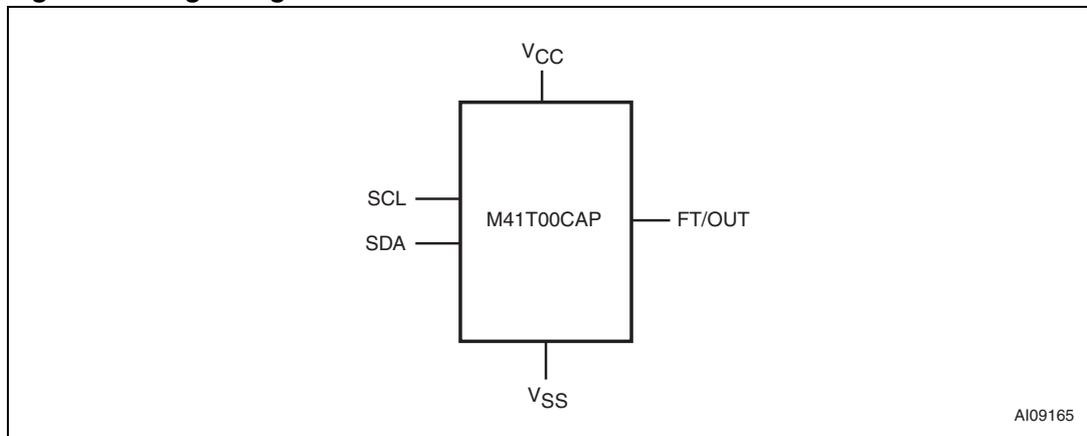
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1 Description

The M41T00CAP is a low-power serial real-time clock (RTC) with integral battery and crystal in ST's 24-pin CAPHAT™ package. It includes a crystal controlled, 32.768 kHz oscillator and has a built-in power sense circuit which detects power failures and automatically switches to the backup battery when a power failure occurs.

Eight registers comprise the clock/calendar function and are configured in binary-coded decimal (BCD) format. Addresses and data are transferred serially via an industry standard, two line, 400 kHz, bidirectional I²C interface. The built-in address register is incremented automatically after each WRITE or READ data byte. The internal lithium coin cell contains ample energy to sustain timekeeping operation for 10 years in the absence of system power. The eight clock address locations contain the century, year, month, date, day, hour, minute, and second in 24-hour BCD format. Corrections for the number of days in a month, including leap year, are made automatically (leap year valid up to year 2100).

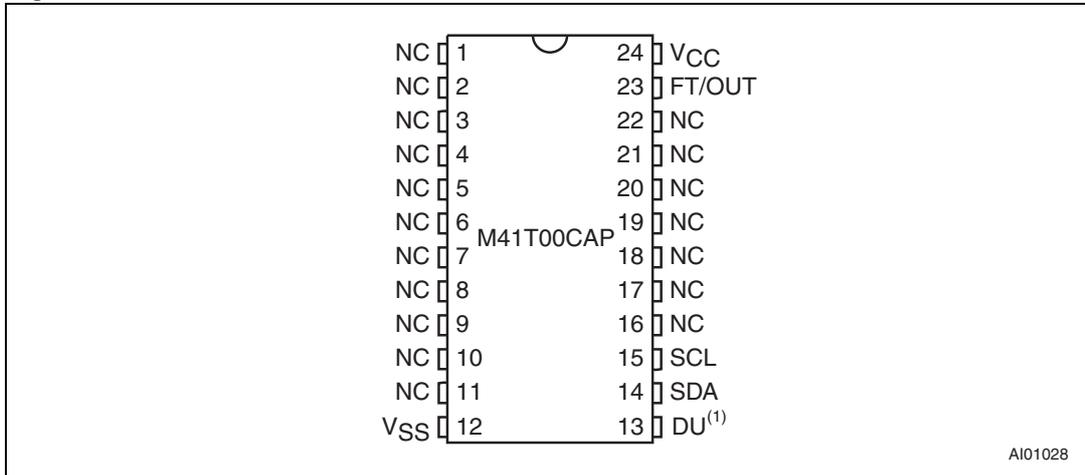
Figure 1. Logic diagram



2 Pin settings

2.1 Pin connection

Figure 2. DIP connections



1. DU is "don't use". Do not connect. Must be allowed to float. Do not connect to V_{CC} or V_{SS}.

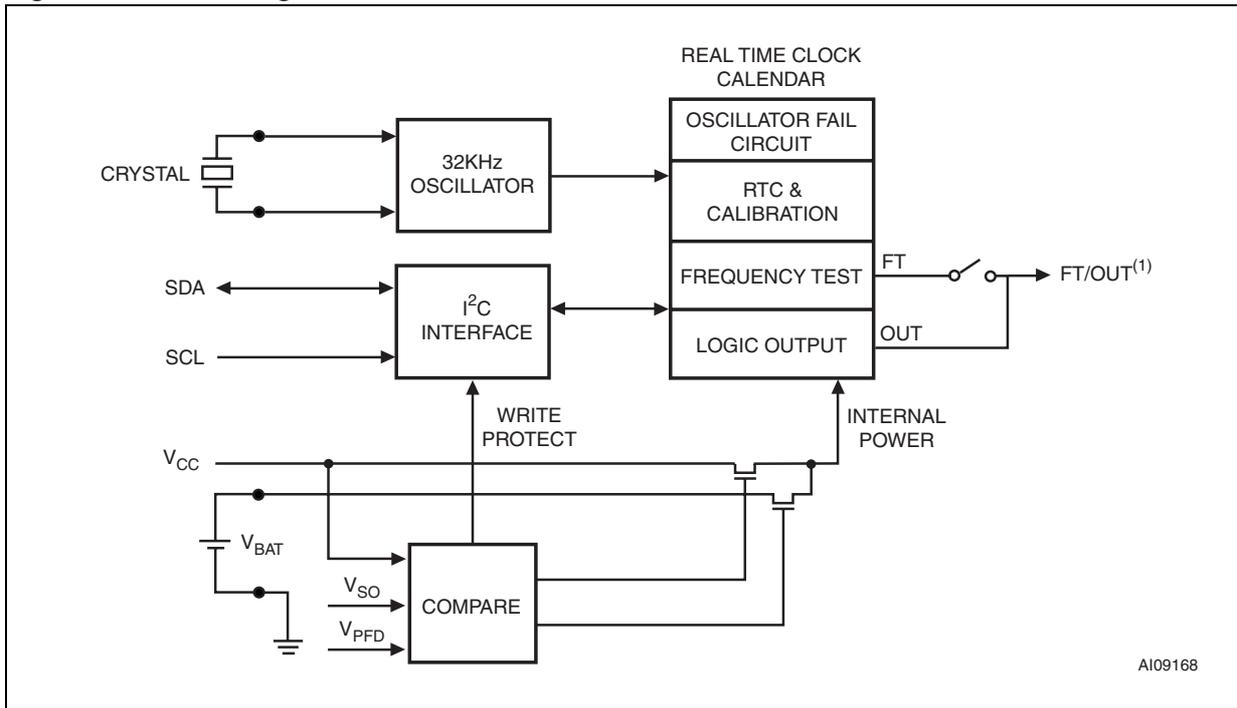
2.2 Pin description

Table 1. Pin description

| Symbol | Name and function |
|-------------------|---|
| FT/OUT | Frequency test / output driver (open drain) |
| SDA | Serial data input/output |
| SCL | Serial clock input |
| V _{CC} | Supply voltage |
| V _{SS} | Ground |
| DU ⁽¹⁾ | Do not use. Do not connect. Reserved for factory use. |
| NC | No connection |

1. DU is "don't use". Do not connect. Must be allowed to float. Do not connect to V_{CC} or V_{SS}.

Figure 3. Block diagram



1. Open drain output

3 Operation

The M41T00CAP clock operates as a slave device on the I²C serial bus. Access is obtained by implementing a start condition followed by the correct slave address (D0h). The 8 bytes contained in the device can then be accessed sequentially in the following order:

1. Seconds register
2. Minutes register
3. Century/hours register
4. Day register
5. Date register
6. Month register
7. Year register
8. Calibration register

The M41T00CAP clock continually monitors V_{CC} for an out-of-tolerance condition. Should V_{CC} fall below V_{PFD} , the device terminates an access in progress and resets the device address counter. Inputs to the device will not be recognized at this time to prevent erroneous data from being written to the device from a an out-of-tolerance system. Once V_{CC} falls below the switchover voltage (V_{SO}), the device automatically switches over to the battery and powers down into an ultra-low current mode of operation to prolong battery life. If V_{BAT} is less than V_{PFD} , the device power is switched from V_{CC} to V_{BAT} when V_{CC} drops below V_{BAT} . If V_{BAT} is greater than V_{PFD} , the device power is switched from V_{CC} to V_{BAT} when V_{CC} drops below V_{PFD} . Upon power-up, the device switches from battery to V_{CC} at V_{SO} . When V_{CC} rises above V_{PFD} , the inputs will be recognized.

For more information on battery storage life refer to application note AN1012.

3.1 Wire bus characteristics

The bus is intended for communication between different ICs. It consists of two lines: a bidirectional data signal (SDA) and a clock signal (SCL). Both the SDA and SCL lines must be connected to a positive supply voltage via a pull-up resistor.

The following protocol has been defined:

- Data transfer may be initiated only when the bus is not busy.
- During data transfer, the data line must remain stable whenever the clock line is high.
- Changes in the data line, while the clock line is high, will be interpreted as control signals.

Accordingly, the following bus conditions have been defined:

3.2 Bus not busy

Both data and clock lines remain high.

3.3 Start data transfer

A change in the state of the data line, from high to low, while the clock is high, defines the START condition.

3.4 Stop data transfer

A change in the state of the data line, from low to high, while the clock is high, defines the STOP condition.

3.5 Data valid

The state of the data line represents valid data when after a start condition, the data line is stable for the duration of the high period of the clock signal. The data on the line may be changed during the low period of the clock signal. There is one clock pulse per bit of data. Each data transfer is initiated with a start condition and terminated with a stop condition. The number of data bytes transferred between the start and stop conditions is not limited. The information is transmitted byte-wide and each receiver acknowledges with a ninth bit. By definition a device that gives out a message is called "transmitter," the receiving device that gets the message is called "receiver." The device that controls the message is called "master." The devices that are controlled by the master are called "slaves."

3.6 Acknowledge

Each byte of eight bits is followed by one acknowledge bit. This acknowledge bit is a low level put on the bus by the receiver whereas the master generates an extra acknowledge related clock pulse. A slave receiver which is addressed is obliged to generate an acknowledge after the reception of each byte that has been clocked out of the master transmitter. The device that acknowledges has to pull down the SDA line during the acknowledge clock pulse in such a way that the SDA line is a stable low during the high period of the acknowledge related clock pulse. Of course, setup and hold times must be taken into account. A master receiver must signal an end of data to the slave transmitter by not generating an acknowledge on the last byte that has been clocked out of the slave. In this case the transmitter must leave the data line high to enable the master to generate the STOP condition.

Figure 4. Serial bus data transfer sequence

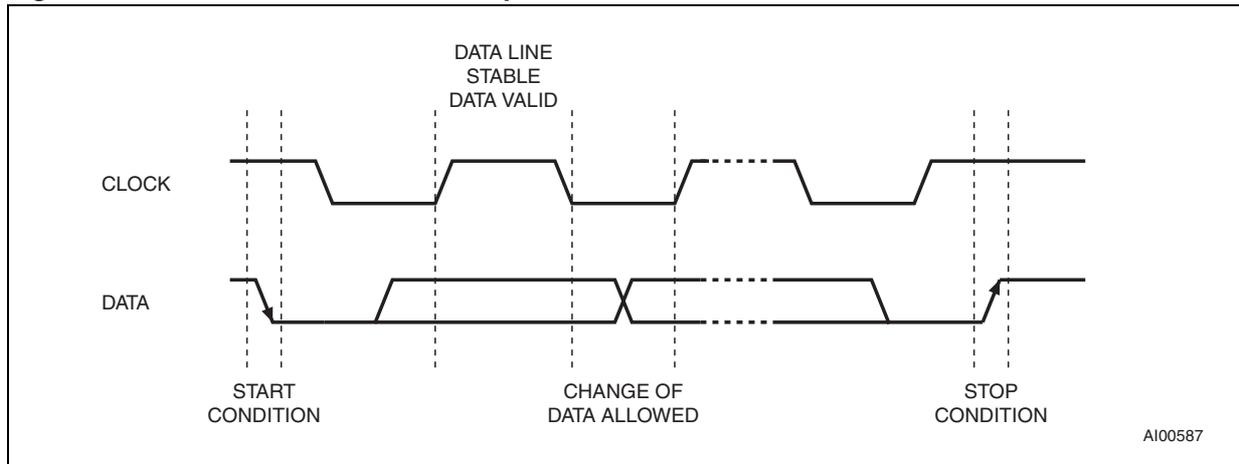
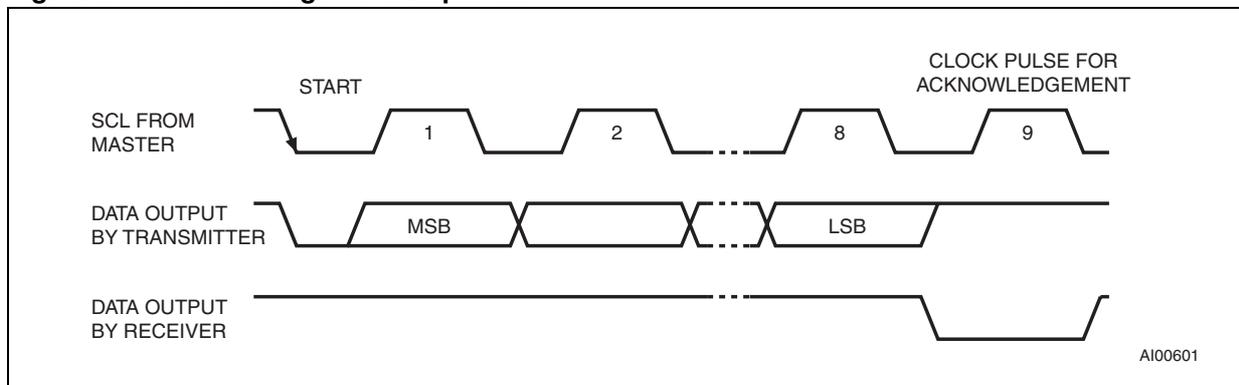


Figure 5. Acknowledgement sequence



3.7 READ mode

In this mode the master reads the M41T00CAP slave after setting the slave address (see [Figure 7](#)). Following the WRITE mode control bit ($R/W = 0$) and the acknowledge bit, the word address 'An' is written to the on-chip address pointer. Next the START condition and slave address are repeated followed by the READ mode control bit ($R/W = 1$). At this point the master transmitter becomes the master receiver. The data byte which was addressed will be transmitted and the master receiver will send an acknowledge bit to the slave transmitter. The address pointer is only incremented on reception of an acknowledge clock. The M41T00CAP slave transmitter will now place the data byte at address $An+1$ on the bus, the master receiver reads and acknowledges the new byte and the address pointer is incremented to "An+2."

This cycle of reading consecutive addresses will continue until the master receiver sends a STOP condition to the slave transmitter.

The system-to-user transfer of clock data will be halted whenever the address being read is a clock address (00h to 06h). The updating will resume upon a stop condition or when the pointer increments to any non-clock address (07h).

Note: This is true both in READ mode and WRITE mode.

An alternate READ mode may also be implemented whereby the master reads the M41T00S slave without first writing to the (volatile) address pointer. The first address that is read is the last one stored in the pointer (see [Figure 8](#)).

Figure 6. Slave address location

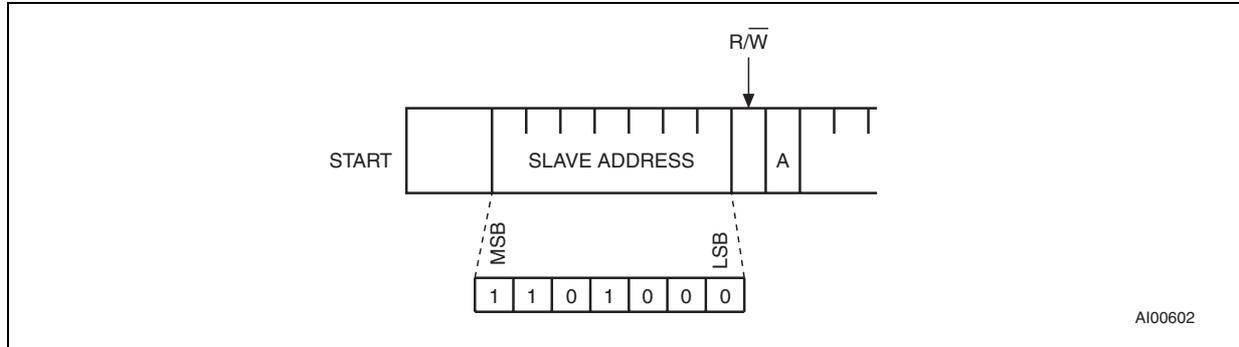


Figure 7. READ mode sequence

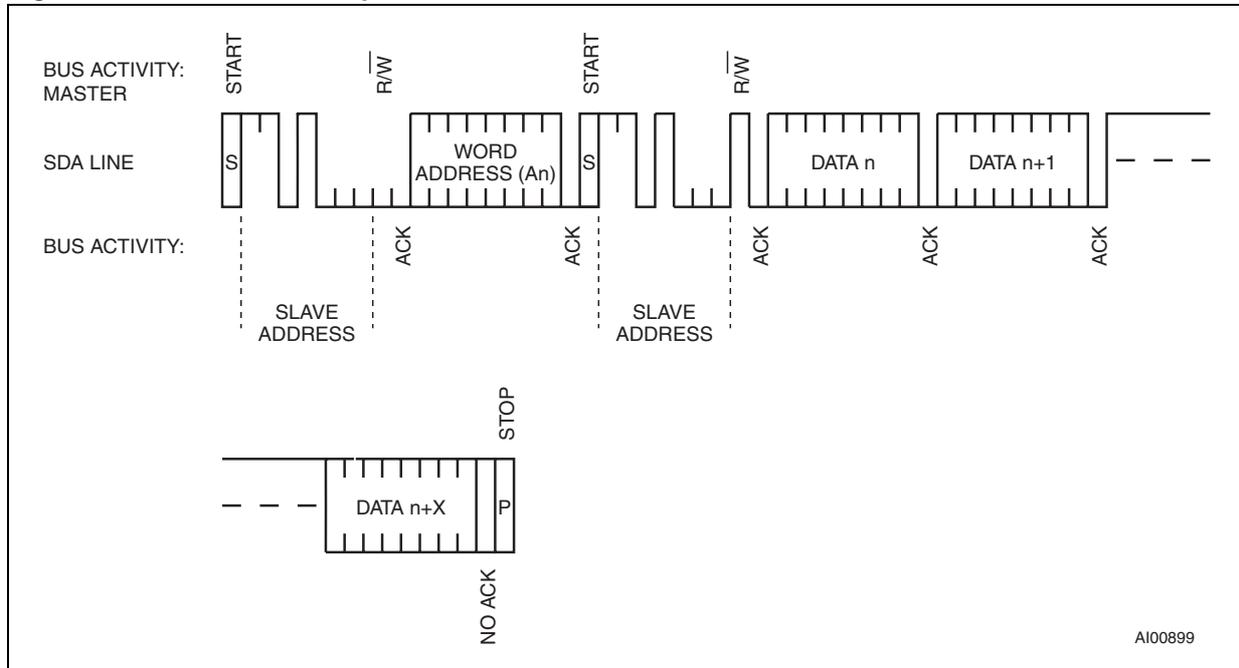
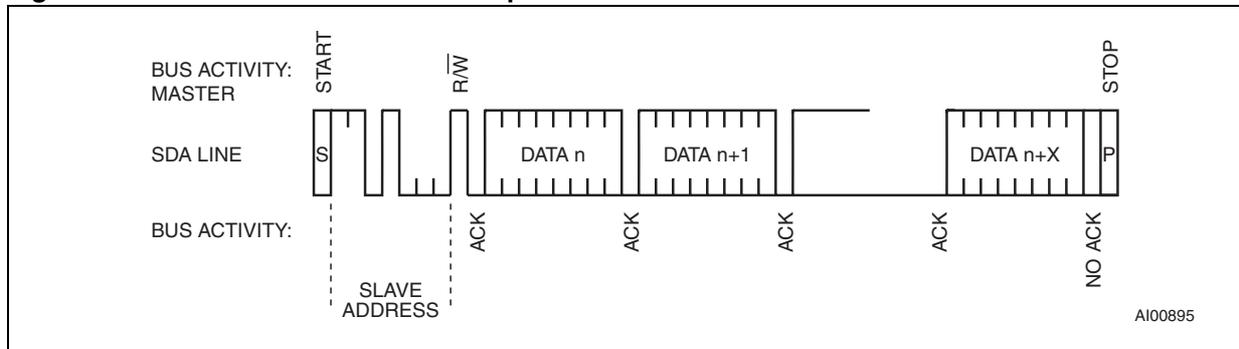


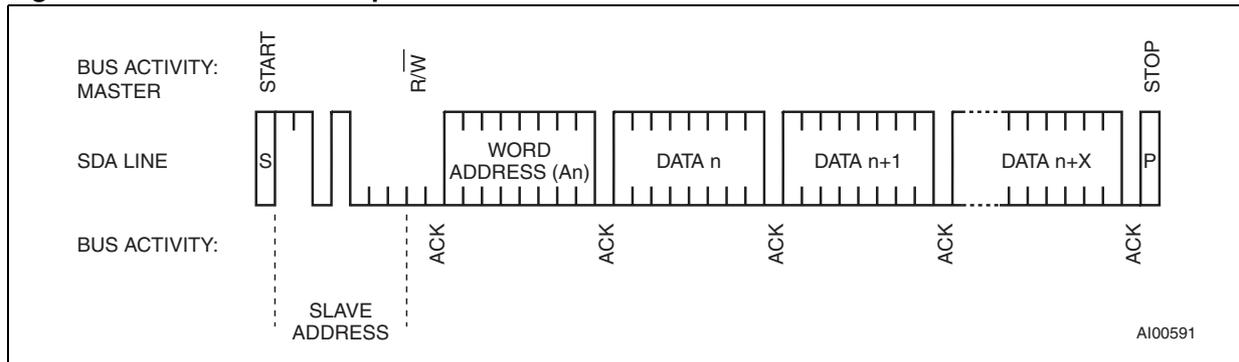
Figure 8. Alternative READ mode sequence



3.8 WRITE mode

In this mode the master transmitter transmits to the M41T00CAP slave receiver. Bus protocol is shown in *Figure 9*. Following the START condition and slave address, a logic '0' (R/W=0) is placed on the bus and indicates to the addressed device that word address "An" will follow and is to be written to the on-chip address pointer. The data word to be written to the memory is strobed in next and the internal address pointer is incremented to the next address location on the reception of an acknowledge clock. The device slave receiver will send an acknowledge clock to the master transmitter after it has received the slave address and again after it has received the word address and after each data byte.

Figure 9. WRITE mode sequence



3.9 Data retention mode

With valid V_{CC} applied, the M41T00CAP can be accessed as described above with READ or WRITE cycles. Should the supply voltage decay, the power input will be switched from the V_{CC} pin to the battery when V_{CC} falls below the battery backup switchover voltage (V_{SO}). At this time the clock registers will be maintained by the internal battery supply. On power-up, when V_{CC} returns to a nominal value, write protection continues for t_{REC} after V_{CC} rises above V_{SO} .

4 Clock operation

The 8-byte register map (see [Table 2](#)) is used to both set the clock and to read the date and time from the clock, in a binary coded decimal format. Seconds, minutes, and hours are contained within the first three registers. Bits D6 and D7 of clock register 02h (century/hours register) contain the century enable bit (CEB) and the century bit (CB). Setting CEB to a '1' will cause CB to toggle, either from '0' to '1' or from '1' to '0' at the turn of the century (depending upon its initial state). If CEB is set to a '0,' CB will not toggle. Bits D0 through D2 of Register 03h contain the Day (day of week). Registers 04h, 05h, and 06h contain the date (day of month), month and years. The eighth clock register is the calibration register (this is described in the clock calibration section). Bit D7 of register 00h contains the STOP bit (ST). Setting this bit to a '1' will cause the oscillator to stop. If the device is expected to spend a significant amount of time on the shelf, the oscillator may be stopped to reduce current drain. When reset to a '0' the oscillator restarts within one second. The seven clock registers may be read one byte at a time, or in a sequential block. The calibration register (address location 07h) may be accessed independently. Provision has been made to ensure that a clock update does not occur while any of the seven clock addresses are being read. If a clock address is being read, an update of the clock registers will be halted. This will prevent a transition of data during the READ.

Table 2. TIMEKEEPER[®] register map

| Addr | | | | | | | | | Function/range BCD format | |
|------|----------|------------|----------|-------------|------------------------|-------------|------|---------------|---------------------------|--|
| | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 | | |
| 00h | ST | 10 seconds | | | Seconds | | | Seconds | 00-59 | |
| 01h | OF | 10 minutes | | | Minutes | | | Minutes | 00-59 | |
| 02h | CEB | CB | 10 hours | | Hours (24-hour format) | | | Century/hours | 0-1/00-23 | |
| 03h | 0 | 0 | 0 | 0 | 0 | Day of week | | Day | 01-7 | |
| 04h | 0 | 0 | 10 date | | Date: day of month | | | Date | 01-31 | |
| 05h | 0 | 0 | 0 | 10M | Month | | | Month | 01-12 | |
| 06h | 10 years | | | Year | | | Year | 00-99 | | |
| 07h | OUT | FT | S | Calibration | | | | Calibration | | |

Keys:

- 0 = must be set to '0'
- CB = century bit
- CEB = century enable bit
- FT = frequency test bit
- OF = oscillator fail bit
- OUT = output level
- S = sign bit
- ST = stop bit

4.1 Clock registers

The M41T00CAP has 8 internal registers which contain clock and calibration data. These registers are memory locations which contain external (user accessible) and internal copies of the data (usually referred to as BiPORT™ TIMEKEEPER cells). The external copies are independent of internal functions except that they are updated periodically by the simultaneous transfer of the incremented internal copy. The system-to-user transfer of clock data will be halted whenever the address being read is a clock address (00h to 06h). The update will resume either due to a stop condition or when the pointer increments to any non-clock address (07h). Clock registers store data in BCD. The calibration register stores data in binary format. The internal divider (or clock) chain will be reset upon the completion of a WRITE to any clock address.

4.2 Calibrating the clock

The M41T00CAP is driven by a quartz-controlled oscillator with a nominal frequency of 32,768 Hz. The devices are tested not to exceed ± 23 ppm (parts per million) oscillator frequency error at 25°C, which equates to about ± 1 minute per month (see [Figure 10](#)). When the Calibration circuit is properly employed, accuracy improves to better than ± 2 ppm at 25°C. The oscillation rate of crystals changes with temperature. The M41T00CAP design employs periodic counter correction. The calibration circuit adds or subtracts counts from the oscillator divider circuit at the divide by 256 stage, as shown in [Figure 11](#). The number of times pulses which are blanked (subtracted, negative calibration) or split (added, positive calibration) depends upon the value loaded into the five calibration bits found in the calibration register. Adding counts speeds the clock up, subtracting counts slows the clock down. The calibration bits occupy the five lower order bits (D4-D0) in the calibration register 07h. These bits can be set to represent any value between 0 and 31 in binary form. Bit D5 is a Sign Bit; '1' indicates positive calibration, '0' indicates negative calibration. Calibration occurs within a 64 minute cycle. The first 62 minutes in the cycle may, once per minute, have one second either shortened by 128 or lengthened by 256 oscillator cycles. If a binary '1' is loaded into the register, only the first 2 minutes in the 64 minute cycle will be modified; if a binary 6 is loaded, the first 12 will be affected, and so on. Therefore, each calibration step has the effect of adding 512 or subtracting 256 oscillator cycles for every 125,829,120 actual oscillator cycles, that is +4.068 or -2.034 ppm of adjustment per calibration step in the calibration register (see [Figure 11](#)). Assuming that the oscillator is running at exactly 32,768 Hz, each of the 31 increments in the calibration byte would represent +10.7 or -5.35 seconds per month which corresponds to a total possible adjustment range of +5.5 or -2.75 minutes per month.

Two methods are available for ascertaining how much calibration a given M41T00CAP may require. The first involves setting the clock, letting it run for a month and comparing it to a known accurate reference and recording deviation over a fixed period of time. Calibration values, including the number of seconds lost or gained in a given period, can be found in application note AN934, "TIMEKEEPER® calibration." This allows the designer to give the end user the ability to calibrate the clock as the environment requires, even if the final product is packaged in a non-user serviceable enclosure. The designer could provide a simple utility that accesses the calibration byte. The second approach is better suited to a manufacturing environment, and involves the use of the FT/OUT pin. The pin will toggle at 512 Hz, when the stop bit (ST, D7 of 00h) is '0,' and the frequency test bit (FT, D6 of 07h) is '1.' Any deviation from 512 Hz indicates the degree and direction of oscillator frequency shift at the test temperature. For example, a reading of 512.010124 Hz would indicate a +20 ppm oscillator frequency error, requiring a -10 (XX001010) to be loaded into the calibration byte

for correction. Note that setting or changing the calibration byte does not affect the frequency test output frequency. The FT/OUT pin is an open drain output which requires a pull-up resistor to V_{CC} for proper operation. A 500-10 kΩ resistor is recommended in order to control the rise time. The FT bit is cleared on power-down.

Figure 10. Crystal accuracy across temperature

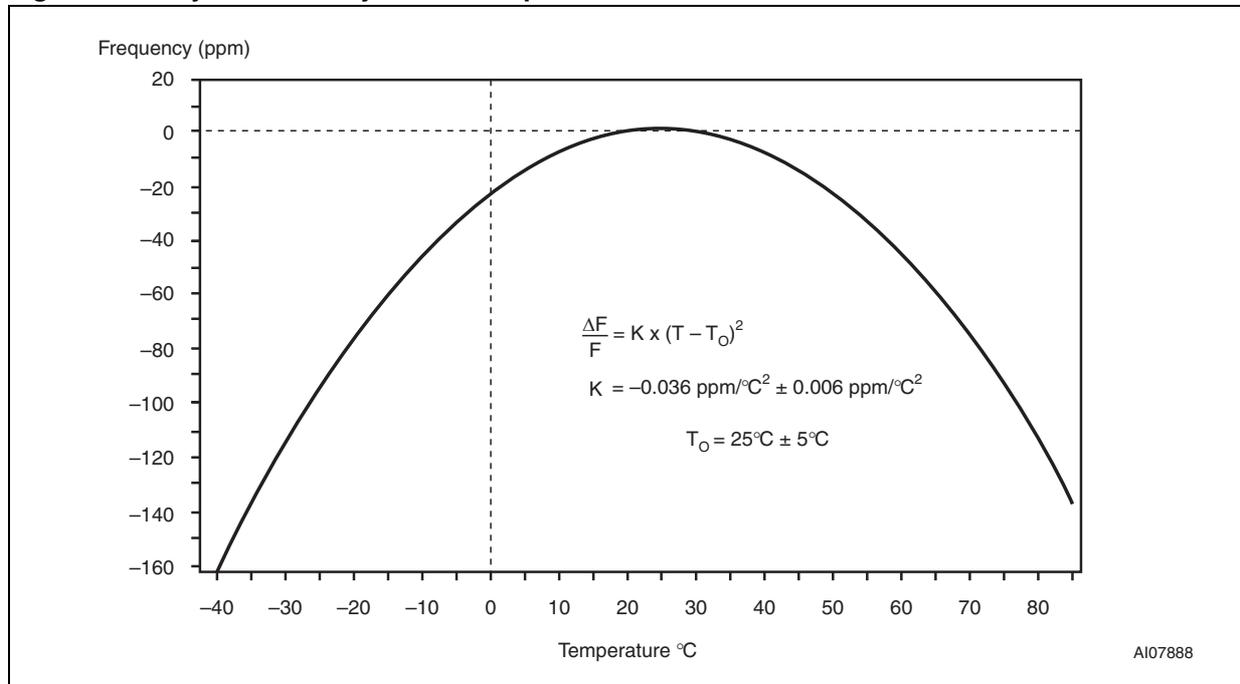
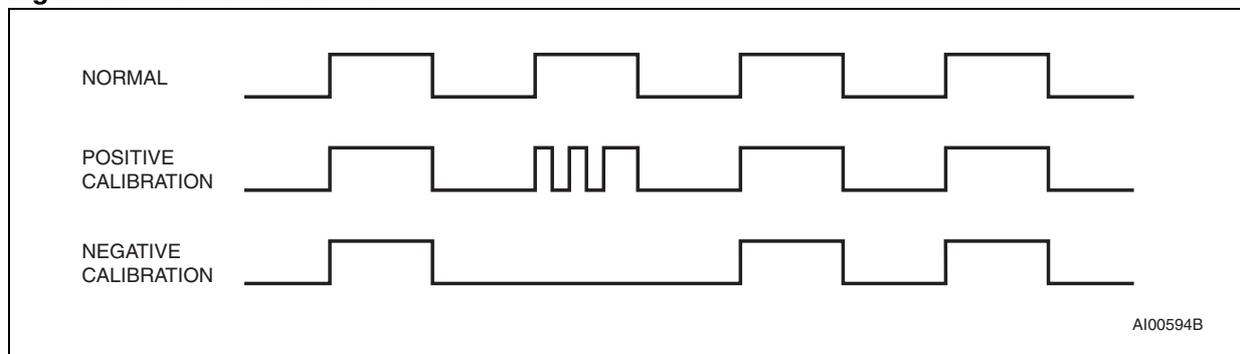


Figure 11. Clock calibration



4.3 Century bit

Bits D7 and D6 of clock register 02h contain the century enable bit (CEB) and the century bit (CB). Setting CEB to a '1' will cause CB to toggle, either from a '0' to '1' or from '1' to '0' at the turn of the century (depending upon its initial state). If CEB is set to a '0,' CB will not toggle.

4.4 Oscillator fail detection

If the oscillator fail bit (OF) is internally set to '1,' this indicates that the oscillator has either stopped, or was stopped for some period of time and can be used to judge the validity of the clock and date data. In the event the OF bit is found to be set to '1' at any time other than the initial power-up, the STOP bit (ST) should be written to a '1,' then immediately reset to '0.' This will restart the oscillator. The following conditions can cause the OF bit to be set:

- The first time power is applied (defaults to a '1' on power-up).
- The voltage present on V_{CC} is insufficient to support oscillation.
- The ST bit is set to '1'.
- External interference of the crystal.

The OF bit will remain set to '1' until written to logic '0.' The oscillator must have started and run for at least 4 seconds before attempting to reset the OF bit to '0.'

4.5 Output driver pin

When the FT bit is not set, the FT/OUT pin becomes an output driver that reflects the contents of D7 of the calibration register. In other words, when D7 (OUT bit) and D6 (FT bit) of address location 07h are '0's, then the FT/OUT pin will be driven low.

Note: The FT/OUT pin is an open drain which requires an external pull-up resistor.

4.6 Initial power-on default

Upon initial application of power to the device, the ST and FT bits are set to a '0' state, and the OF and OUT bits will be set to a '1.' All other register bits will initially power on in a random state (see [Table 3](#)).

Table 3. Preferred default values

| Condition | ST | OUT | FT | OF |
|--|----|-----|----|----|
| Initial power-up ⁽¹⁾ | 0 | 1 | 0 | 1 |
| Subsequent power-up (with battery backup) ⁽²⁾ | UC | UC | 0 | UC |

1. State of other control bits undefined.

2. UC = unchanged

5 Maximum ratings

Stressing the device above the rating listed in the absolute maximum ratings table may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the operating sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Table 4. Absolute maximum ratings

| Sym | Parameter | Value | Unit |
|------------------------------------|---|------------------------------|------|
| T _{STG} | Storage temperature (V _{CC} off, oscillator off) | –55 to 125 | °C |
| V _{CC} | Supply voltage | –0.3 to 7 | V |
| T _{SLD} ⁽¹⁾⁽²⁾ | Lead solder temperature for 10 seconds | 260 | °C |
| V _{IO} | Input or output voltages | –0.3 to V _{CC} +0.3 | V |
| I _O | Output current | 20 | mA |
| P _D | Power dissipation | 1 | W |

1. Soldering temperature of the IC leads is to not exceed 260 °C for 10 seconds. In order to protect the lithium battery, preheat temperatures must be limited such that the battery temperature does not exceed +85 °C. Furthermore, the devices shall not be exposed to IR reflow.
2. For DIP packaged devices, ultrasonic vibrations should not be used for post-solder cleaning to avoid damaging the crystal.

Caution: Negative undershoots below –0.3 volts are not allowed on any pin while in the battery backup mode.

6 DC and AC parameters

This section summarizes the operating and measurement conditions, as well as the DC and AC characteristics of the device. The parameters in the following DC and AC characteristic tables are derived from tests performed under the measurement conditions listed in [Table 5: Operating and AC measurement conditions](#). Designers should check that the operating conditions in their projects match the measurement conditions when using the quoted parameters.

Table 5. Operating and AC measurement conditions

| Parameter | M41T00CAP |
|---|------------------------------|
| Supply voltage (V_{CC}) | 2.7 to 5.5 V |
| Ambient operating temperature (T_A) | 0 to 70 °C |
| Load capacitance (C_L) | 100 pF |
| Input rise and fall times | ≤ 5 ns |
| Input pulse voltages | 0.2 V_{CC} to 0.8 V_{CC} |
| Input and output timing ref. voltages | 0.3 V_{CC} to 0.7 V_{CC} |

Note: Output Hi-Z is defined as the point where data is no longer driven.

Figure 12. AC measurement I/O waveform

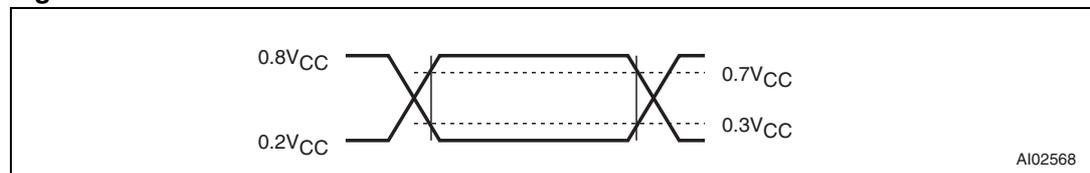


Table 6. Capacitance

| Symbol | Parameter ⁽¹⁾⁽²⁾ | Min | Max | Unit |
|-----------------|---|-----|-----|------|
| C_{IN} | Input capacitance | - | 7 | pF |
| $C_{OUT}^{(3)}$ | Output capacitance | - | 10 | pF |
| t_{LP} | Low-pass filter input time constant (SDA and SCL) | - | 50 | ns |

1. Effective capacitance measured with power supply at 5 V; sampled only, not 100% tested.
2. At 25 °C, $f = 1$ MHz.
3. Outputs deselected.

Table 7. DC characteristics

| Sym | Parameter | Test condition ⁽¹⁾ | Min | Typ | Max | Unit |
|------------------|--|--|---------------------|-----|-----------------------|------|
| I _{LI} | Input leakage current | 0V ≤ V _{IN} ≤ V _{CC} | | - | ±1 | μA |
| I _{LO} | Output leakage current | 0V ≤ V _{OUT} ≤ V _{CC} | | - | ±1 | μA |
| I _{CC1} | Supply current | Switch freq = 400 kHz | | - | 300 | μA |
| I _{CC2} | Supply current (standby) | SCL = 0 Hz All inputs ≥ V _{CC} - 0.2 V ≤ V _{SS} + 0.2 V | | - | 70 | μA |
| V _{IL} | Input low voltage | | -0.3 | - | 0.3 V _{CC} | V |
| V _{IH} | Input high voltage | | 0.7 V _{CC} | - | V _{CC} + 0.3 | V |
| V _{OL} | Output low voltage | I _{OL} = 3.0 mA | | - | 0.4 | V |
| | Output low voltage (open drain) ⁽²⁾ | I _{OL} = 10 mA | | - | 0.4 | V |
| | Pull-up supply voltage (open drain) ⁽²⁾ | | | - | 5.5 | V |

- Valid for ambient operating temperature: T_A = 0 to 70 °C; V_{CC} = 2.7 to 5.5 V (except where noted).
- For FT/OUT pin (open drain).

Figure 13. Power down/up mode AC waveforms

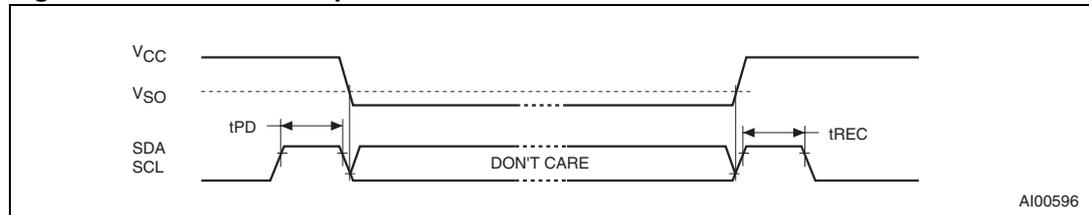


Table 8. Power down/up AC characteristics

| Symbol | Parameter ⁽¹⁾⁽²⁾ | Min | Typ | Max | Unit |
|------------------|--|-----|-----|-----|------|
| t _{PD} | SCL and SDA at V _{IH} before power down | 0 | - | - | nS |
| t _{rec} | SCL and SDA at V _{IH} after power up | 10 | - | - | μS |

- V_{CC} fall time should not exceed 5 mV/μs.
- Valid for ambient operating temperature: T_A = 0 to 70 °C; V_{CC} = 2.7 to 5.5 V (except where noted).

Table 9. Power down/up trip points DC characteristics

| Sym | Parameter (1)(2) | Min | Typ | Max | Unit |
|--------------------------------|-----------------------------------|-------------------------------------|-----|------------------|-------|
| V _{PFD} | Power-fail deselect | 2.5 | 2.6 | 2.7 | V |
| | Hysteresis | | 25 | | mV |
| V _{SO} | Battery backup switchover voltage | V _{BAT} < V _{PFD} | | V _{BAT} | V |
| | | V _{BAT} > V _{PFD} | | V _{PFD} | V |
| | Hysteresis | | 40 | | mV |
| t _{DR} ⁽³⁾ | Expected data retention time | 10 | | | Years |

1. All voltages referenced to V_{SS}.
2. Valid for ambient operating temperature: T_A = -40 to 85 °C; V_{CC} = 2.7 to 5.5 V (except where noted).
3. T_A = 25°C, V_{CC} = 0 V, oscillator on.

Figure 14. Bus timing requirements sequence

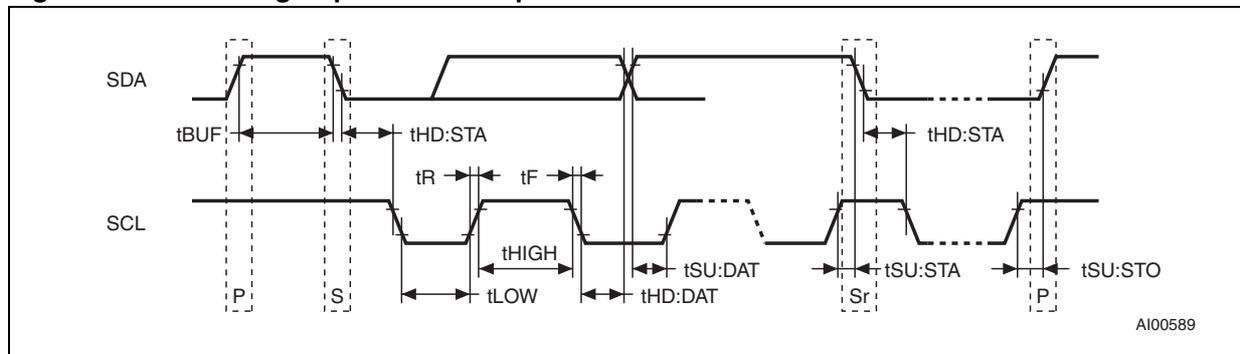


Table 10. AC characteristics

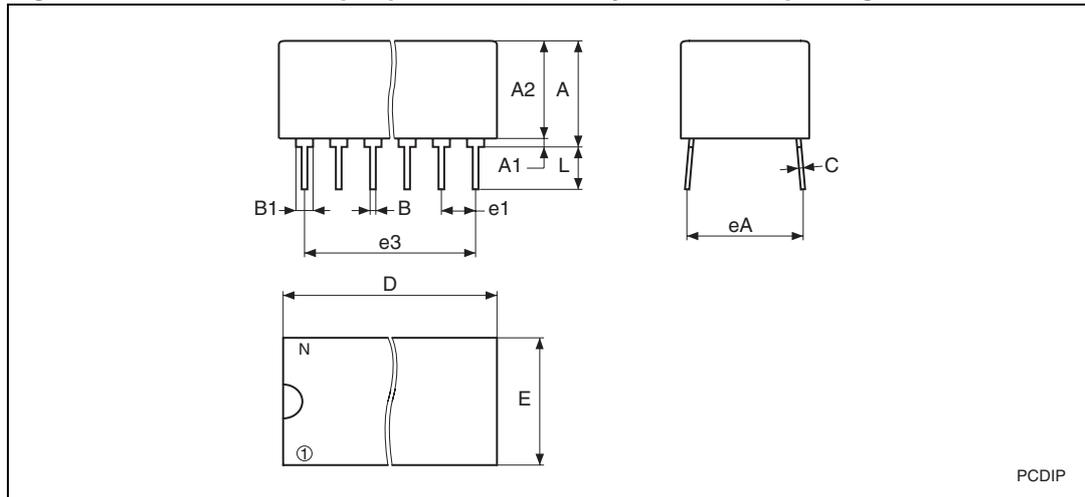
| Sym | Parameter ⁽¹⁾ | Min | Typ | Max | Units |
|------------------------------------|---|-----|-----|-----|-------|
| f _{SCL} | SCL clock frequency | 0 | - | 400 | kHz |
| t _{LOW} | Clock low period | 1.3 | - | | μs |
| t _{HIGH} | Clock high period | 600 | - | | ns |
| t _R | SDA and SCL rise time | | - | 300 | ns |
| t _F | SDA and SCL fall time | | - | 300 | ns |
| t _{HD:STA} | START condition hold time (after this period the first clock pulse is generated) | 600 | - | | ns |
| t _{SU:STA} | START condition setup time (only relevant for a repeated start condition) | 600 | - | | ns |
| t _{SU:DAT} ⁽²⁾ | Data setup time | 100 | - | | ns |
| t _{HD:DAT} | Data hold time | 0 | - | | μs |
| t _{SU:STO} | STOP condition setup time | 600 | - | | ns |
| t _{BUF} | Time the bus must be free before a new transmission can start | 1.3 | - | | μs |

- Valid for ambient operating temperature: T_A = 0 to 70 °C; V_{CC} = 2.7 to 5.5 V (except where noted).
- Transmitter must internally provide a hold time to bridge the undefined region (300 ns max) of the falling edge of SCL.

7 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK[®] is an ST trademark.

Figure 15. PCDIP24 – 24-pin plastic DIP, battery CAPHAT[™], package outline



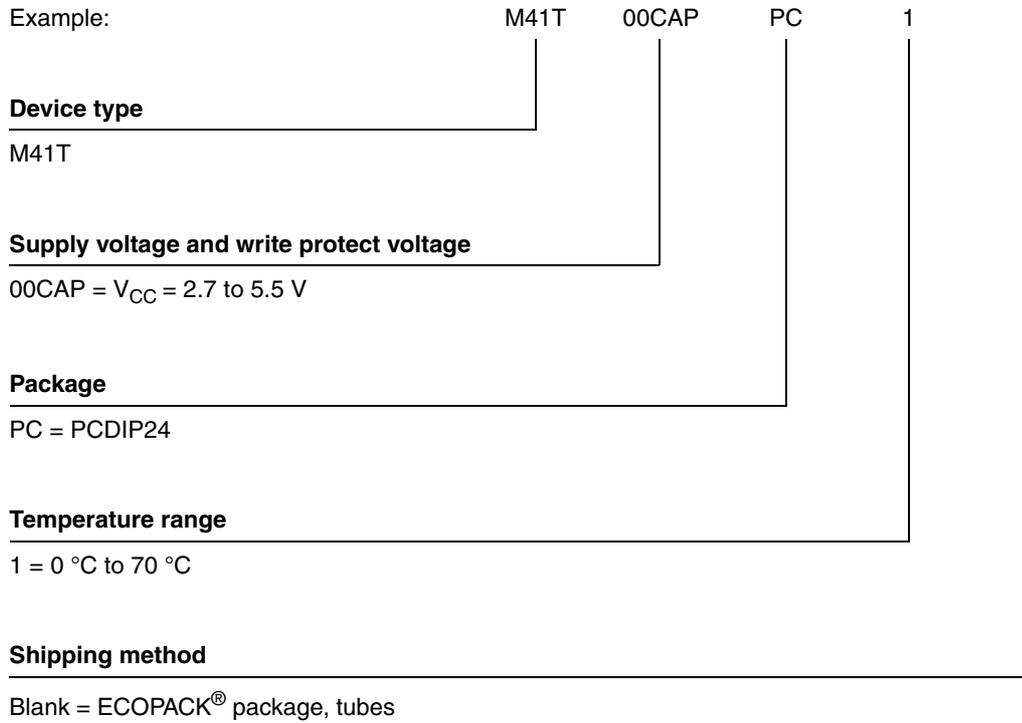
Note: Drawing is not to scale.

Table 11. PCDIP24 – 24-pin plastic DIP, battery CAPHAT[™], package mechanical data

| Symb | mm | | | inches | | |
|------|-------|-------|-------|--------|-------|-------|
| | Typ | Min | Max | Typ | Min | Max |
| A | | 8.89 | 9.65 | | 0.350 | 0.380 |
| A1 | | 0.38 | 0.76 | | 0.015 | 0.030 |
| A2 | | 8.38 | 8.89 | | 0.330 | 0.350 |
| B | | 0.38 | 0.53 | | 0.015 | 0.021 |
| B1 | | 1.14 | 1.78 | | 0.045 | 0.070 |
| C | | 0.20 | 0.31 | | 0.008 | 0.012 |
| D | | 34.29 | 34.80 | | 1.350 | 1.370 |
| E | | 17.83 | 18.34 | | 0.702 | 0.722 |
| e1 | | 2.29 | 2.79 | | 0.090 | 0.110 |
| e3 | 27.94 | | | 1.1 | | |
| eA | | 15.24 | 16.00 | | 0.600 | 0.630 |
| L | | 3.05 | 3.81 | | 0.120 | 0.150 |
| N | | 24 | | | 24 | |

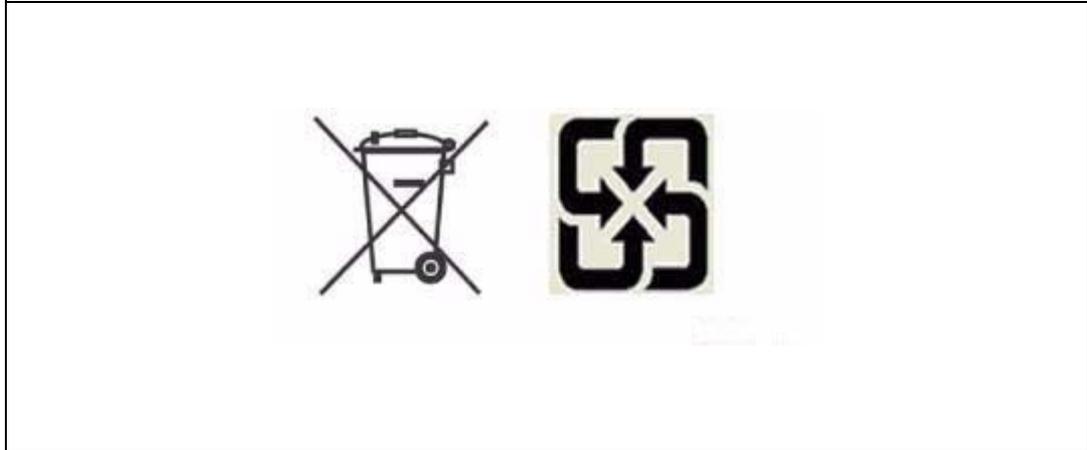
8 Part numbering

Table 12. Ordering information scheme



9 Environmental information

Figure 16. Recycling symbols



This product contains a non-rechargeable lithium (lithium carbon monofluoride chemistry) button cell battery fully encapsulated in the final product.

Recycle or dispose of batteries in accordance with the battery manufacturer's instructions and local/national disposal and recycling regulations.

10 Revision history

Table 13. Document revision history

| Date | Revision | Changes |
|-------------|----------|--|
| 28-Jun-2006 | 1 | First release |
| 20-Mar-2008 | 2 | Document status upgraded to full datasheet; updated title and cover page, Section 1, 3, 4 , Figure 1, 2, 3, 4 , Table 1, 7, 8, 9, 10 . |
| 25-Mar-2009 | 3 | Added Section 9: Environmental information ; updated text in Section 7: Package mechanical data . |
| 27-May-2010 | 4 | Updated Section 5, Table 11 ; reformatted document. |
| 22-Mar-2012 | 5 | Updated title of document; Section 9: Environmental information . |

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